

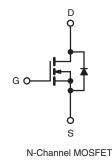
2SK2459N-VB Datasheet N-Channel 200 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	200				
R _{DS(on)} (Ω)	V _{GS} = 10 V	0.265			
Q _g (Max.) (nC)	16				
Q _{gs} (nC)	5				
Q _{gd} (nC)	8				
Configuration	Single				

FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- · Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available





ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	200	v	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V_{GS} at 10 V	T _C = 25 °C	l _D	10		
		T _C = 100 °C		6.5	A	
Pulsed Drain Current ^a			I _{DM}	32		
Linear Derating Factor				0.24	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	36	mJ	
Repetitive Avalanche Current ^a			I _{AR}	7.2	A	
Repetitive Avalanche Energy ^a			E _{AR}	3.7	mJ	
Maximum Power Dissipation	T _C =	25 °C	PD	37	W	
Peak Diode Recovery dV/dtc			dV/dt	5.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 25 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 1.0 mH, $R_G = 25 \Omega$, $I_{AS} = 7.2 \text{ A}$ (see fig. 12). c. $I_{SD} \le 9.2 \text{ A}$, dl/dt $\le 110 \text{ A/}\mu\text{s}$, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$.

d. 1.6 mm from case.





THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R _{thJA}	- 65			*CAM				
Maximum Junction-to-Case (Drain)	R _{thJC}	- 4.1				°C/W			
	uplace other	vice noted							
SPECIFICATIONS $T_J = 25 \text{ °C}$, PARAMETER	SYMBOL			ONE	MIN.	TYP.	MAX.	UNIT	
Static	STMBOL	TES	CONDITI		IVIIIN.	116.	WAA.	UNIT	
Drain-Source Breakdown Voltage	V	V -	$-0 \times 1 - 2$	50 ··· A	200	-	-	v	
0	V _{DS}	$V_{GS} = 0 V$, $I_D = 250 \mu A$			- 200	0.13	-	V/°C	
V _{DS} Temperature Coefficient Gate-Source Threshold Voltage	$\Delta V_{DS}/T_J$	Reference to 25 °C, $I_D = 1 \text{ mA}$			2.0	0.13	4.0	V	
5	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$			-	-	-	-	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA μA	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	25			
Durin Country On Otata Desistance		$V_{DS}=160 \text{ V}, V_{GS}=0 \text{ V}, \text{T}_{J}=150 ^{\circ}\text{C}$ $V_{GS}=10 \text{ V} \qquad \text$		-	-	250			
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	_		-	0.265	-	Ω	
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D =	4.3 A ⁶	2.3	-	-	S	
Dynamic							[1	
Input Capacitance	C _{iss}	V _{GS} = 0 V, V _{DS} = 25 V, f = 1.0 MHz, see fig. 5		-	560	-	- pF		
Output Capacitance	C _{oss}			-	260	-			
Reverse Transfer Capacitance	C _{rss}			-	110	-			
Drain to Sink Capacitance	С		f = 1.0 MHz	2	-	12	-		
Total Gate Charge	Qg		I _D = 9.2 A, V _{DS} = 80 V,	-	-	16	nC		
Gate-Source Charge	Q _{gs}			A, $v_{DS} = 80 v$, g. 6 and 13 ^b	-	-		4.4	
Gate-Drain Charge	Q _{gd}				-	-	7.7		
Turn-On Delay Time	t _{d(on)}				-	8.8	-		
Rise Time	t _r	$\begin{array}{l} V_{DD} \;\; = \; 100 \; V, \; I_{D} = \; 9.2 \; A, \\ R_{G} \; = \; 18 \; \Omega, \; R_{D} = \; 5.2 \; \Omega, \\ \; \; \; \; \; \; \; \; \; \; \; \; \; \; \; \; \; \; $		-	30	-	ns		
Turn-Off Delay Time	t _{d(off)}			-	19	-			
Fall Time	t _f			-	20	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	Ls			-	7.5	-			
Drain-Source Body Diode Characteristic	s								
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	10	-	A		
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode			-	32		-	
Body Diode Voltage	V _{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = 7.2 \ A, \ V_{GS} = 0 \ V^b$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^{\circ}C, I_F = 9.2 \text{ A}, dI/dt = 100 \text{ A}/\mu \text{s}^{b}$		-	130	260	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.65	1.3	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)						_D)	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

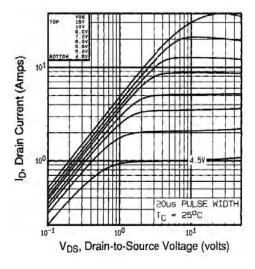


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

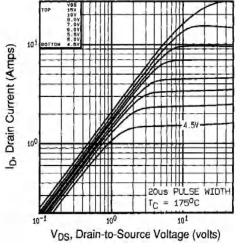


Fig. 2 - Typical Output Characteristics, T_C = 175 $^\circ C$

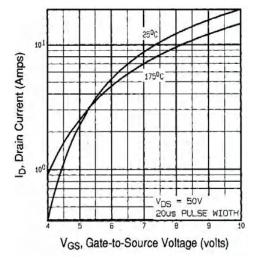


Fig. 3 - Typical Transfer Characteristics

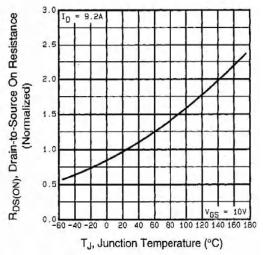


Fig. 4 - Normalized On-Resistance vs. Temperature



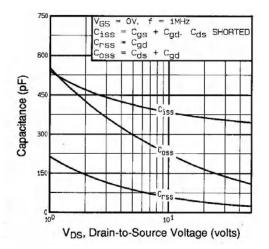


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

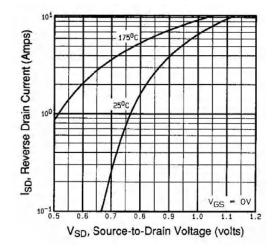


Fig. 7 - Typical Source-Drain Diode Forward Voltage

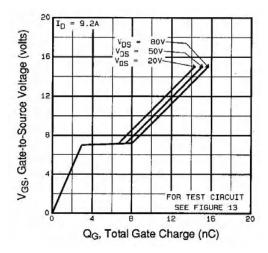


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

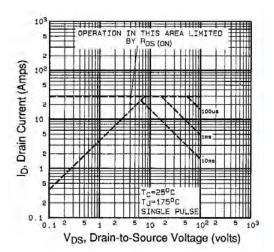


Fig. 5 - Fig. 8 - Maximum Safe Operating Area



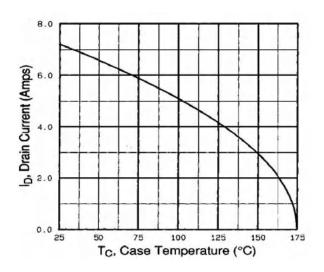


Fig. 9 - Maximum Drain Current vs. Case Temperature

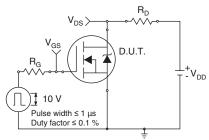


Fig. 10a - Switching Time Test Circuit

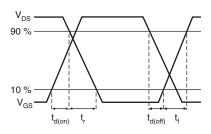
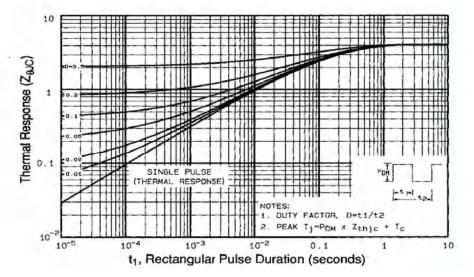
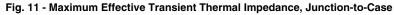
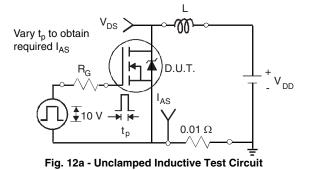


Fig. 10b - Switching Time Waveforms







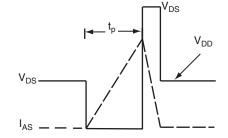
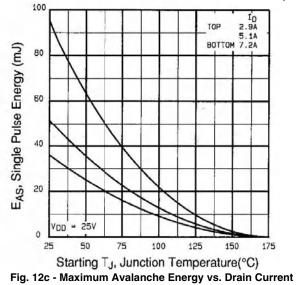


Fig. 12b - Unclamped Inductive Waveforms







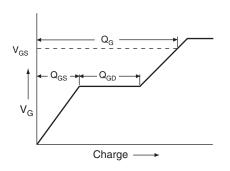
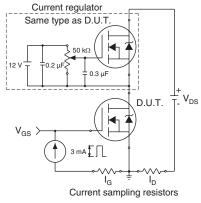
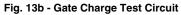
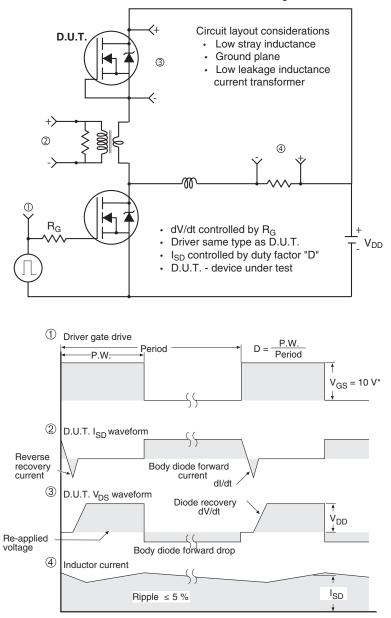


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



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